

Indian Institute of Technology

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Semiconductor Devices
End-Semester(2009-10) Autumn
Time: 3 Hrs.

course no. EC 21107
Full marks: 100

(Attempt all)

(For specified physical properties do not use attached table)

- a) An Si crystal is to be pulled from the melt and doped arsenic ($k_d=0.3$). If the Si weighs 1 kg, how many grams of arsenic should be introduced to achieve 10^{15} cm^{-3} doping during the initial growth? Atomic weight of As 74.9, density of Si 2.33 g/cm^3 5

b) The ionic radii of Na^+ (atomic weight 23) and Cl^- (atomic weight 35.5) are 1.0 and 1.8 Å, respectively. Treating the ions as hard sphere, calculate the density of NaCl. Compare this with the measured density of 2.17 g/cm^3 . 5
- We define a potential well having energies V as a function of position x , as follows: $V = \infty$ for $x = -0.5 \text{ nm}$ to 0 ; $V = 0 \text{ eV}$ for $x = 0$ to 5 nm ; $V = 10 \text{ eV}$ for $x = 5$ to 6 nm , and $V = 0$ for $x > 6 \text{ nm}$ and $x < -0.5 \text{ nm}$. We put an electron with energy 7 eV in the region x , between 0 and 5 nm . What is the probability of finding the electron at $x < 0 \text{ nm}$? Is there any probability of finding the electron at $x > 6 \text{ nm}$ zero or non zero? What is the probability for $x > 6 \text{ nm}$ if the electron was described by classical mechanics and not quantum mechanics? 10
- a) A Si sample is doped with 10^{17} boron atoms/ cm^3 . What is the electron concentration n_0 at 300 K ? What is the resistivity? n_i of Si $1.5 \times 10^{10}/\text{cm}^3$ $\mu_p = 250 \text{ cm}^2/\text{v.s}$ 5

b) A Ge sample is doped with 3×10^{13} Sb atoms/ cm^3 . Using the requirements of space charge neutrality, calculate the electron concentration n_0 at 300 K . 5
- For a 2-cm-long doped Si bar ($N_d = 10^{16} \text{ cm}^{-3}$) with a cross sectional area = 0.05 cm^2 , what is the current if we apply 10 V across it? If we generate 10^{20} electron hole pairs per second per cm^3 uniformly in the bar and the lifetime $\tau_n = \tau_p = 10^{-4} \text{ s}$, what is the new current? Assume the low-level α_r doesn't change for high-level injection. If the voltage is then increased to $100,000 \text{ V}$, what is the new current? Assume $\mu_p = 500 \text{ cm}^2/\text{V-s}$, $\mu_n = 1070 \text{ cm}^2/\text{V-s}$. $n_0 = 10^{15} / \text{cm}^3$ 10
- a) A Si $p^+ - n$ junction 10^{-2} cm^2 in area has $N_d = 10^{15} \text{ cm}^{-3}$ doping on the n side. Calculate the junction capacitance with a reverse bias of 10 V . 5

b) An abrupt $p^+ - n$ junction is formed in Si with a donor doping of $N_d = 10^{15} \text{ cm}^{-3}$ what is the depletion region thickness W just prior to avalanche breakdown? $V_{br} = 300 \text{ V}$ 5
- You have a symmetric $p - n$ silicon junction ($N_a = N_d = 10^{17} \text{ cm}^{-3}$). If the peak electric field in the junction at breakdown is $5 \times 10^5 \text{ V/cm}$, what is the reverse breakdown voltage in this junction? 10
- An Al-gate p -channel MOS transistor is made on an n -type Si- substrate with $N_d = 5 \times 10^{17} \text{ cm}^{-3}$. The SiO_2 thickness is 100 Å in the gate region, and the effective charge interface charge is $Q_i = 5 \times 10^{10} \text{ qC/cm}^2$. Find W_m , V_{FB} and V_T . Sketch the

C-V curve for this device and give important numbers for the scale. $\epsilon_i = 3.9 \epsilon_s$
 $= 11.8$, $n_i = 1.5 \times 10^{10} / \text{cm}^3$ 10

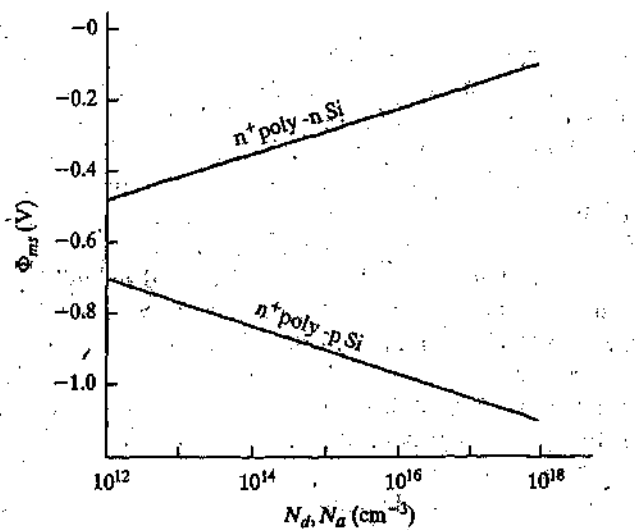
8. Calculate the V_T of a Si n-channel MOSFET for a gate-to-substrate workfunction difference $\Phi_{ms} = -1.5 \text{ eV}$, gate oxide thickness = 100 \AA , $N_A = 10^{18} \text{ cm}^{-3}$, and fixed oxide charge of $5 \times 10^{10} \text{ qC/cm}^2$, for a substrate bias of -2.5 V . At V_T , what are the electron and hole concentration at the oxide-Si interface and deep in the substrate? Sketch a labeled band diagram normal to the surface at V_T , showing the Fermi potential. assume $(kT/q) = 0.026$, $Q_D = 1.071 \times 10^{-6} \text{ C}$ 10
9. For a p-n-p BJT with $N_E > N_B > N_C$, show the dominant current components, with proper arrows, for directions in the normal active mode. If $I_{E_p} = 10 \text{ mA}$, $I_{E_n} = 100 \text{ \mu A}$, $I_{C_p} = 9.8 \text{ mA}$, and $I_{C_n} = 1 \text{ \mu A}$, calculate the base transport factor, emitter injection efficiency, common-base current gain, common-emitter current gain, and I_{CBO} . If the minority stored base charge is $4.9 \times 10^{-11} \text{ C}$, calculate the base transit time and lifetime. 10
10. A Si p-n-p BJT has the following parameters at room temperatures at room temperature.

Emitter: $N_a = 5 \times 10^{18} \text{ cm}^{-3}$, $\tau_n = 100 \text{ ps}$, $\mu_n = 150 \text{ cm}^2/\text{V-s}$ $\mu_p = 100 \text{ cm}^2/\text{V-s}$ Base width $W_b = 0.2 \text{ \mu m}$ Area = 10^{-4} cm^2 ,

Base: $N_d = 10^{16}$, $\tau_p = 2500 \text{ ps}$, $\mu_n = 1500$, $\mu_p = 400$

Collector: $N_a = 10^{15}$, $\tau_n = 2 \text{ \mu s}$, $\mu_n = 1500$, $\mu_p = 450$

Calculate the β of the transistor from B and γ , and using the charge control model. 10



Properties of Semiconductor Materials

		E_g (eV)	μ_n (cm ² /Vs)	μ_p (cm ² /Vs)	m_n^*/m_0 (m_e, m_h)	m_p^*/m_0 (m_h, m_h)	a (Å)	ϵ_r	Density (g/cm ³)	Melting point (°C)
Si	(I/D)	1.11	1350	480	0.98, 0.19	0.16, 0.49	5.43	11.8	2.33	1415
Ge	(I/D)	0.67	3900	1900	1.64, 0.082	0.04, 0.28	5.65	16	5.32	936
SiC (α)	(I/W)	2.86	500	—	0.6	1.0	3.08	10.2	3.21	2830
AlP	(I/Z)	2.45	80	—	—	0.2, 0.63	5.46	9.8	2.40	2000
AlAs	(I/Z)	2.16	1200	420	2.0	0.15, 0.76	5.66	10.9	3.60	1740
AlSb	(I/Z)	1.6	200	300	0.12	0.98	6.14	11	4.26	1080
GaP	(I/Z)	2.26	300	150	1.12, 0.22	0.14, 0.79	5.45	11.1	4.13	1467
GaAs	(d/Z)	1.43	8500	400	0.067	0.074, 0.50	5.65	13.2	5.31	1238
GaN	(d/Z, W)	3.4	380	—	0.19	0.60	4.5	12.2	6.1	2530
GaSb	(d/Z)	0.7	5000	1000	0.042	0.06, 0.23	6.09	15.7	5.61	712
InP	(d/Z)	1.35	4000	100	0.077	0.089, 0.85	5.87	12.4	4.79	1070
InAs	(d/Z)	0.36	22600	200	0.023	0.025, 0.41	6.06	14.6	5.67	943
InSb	(d/Z)	0.18	10 ⁵	1700	0.014	0.015, 0.40	6.48	17.7	5.78	525
ZnS	(d/Z, W)	3.6	180	10	0.28	—	5.409	8.9	4.09	1650*
ZnSe	(d/Z)	2.7	600	28	0.14	0.60	5.671	9.2	5.65	1100*
ZnTe	(d/Z)	2.25	530	100	0.18	0.65	6.101	10.4	5.51	1238*
CdS	(d/W, Z)	2.42	250	15	0.21	0.80	4.137	8.9	4.82	1475
CdSe	(d/W)	1.73	800	—	0.13	0.45	4.30	10.2	5.81	1258
CdTe	(d/Z)	1.58	1050	100	0.10	0.37	6.482	10.2	6.20	1098
PbS	(I/H)	0.37	575	200	0.22	0.29	5.936	17.0	7.6	1119
PbSe	(I/H)	0.27	1500	1500	—	—	6.147	23.6	8.73	1081
PbTe	(I/H)	0.29	6000	4000	0.17	0.20	6.452	30	8.16	925

All values at 300 K.

*Vaporizes

Physical Constants and Conversion Factors¹

Avogadro's number	$N_A = 6.02 \times 10^{23}$ molecules/mole
Boltzmann's constant	$k = 1.38 \times 10^{-23}$ J/K $= 8.62 \times 10^{-5}$ eV/K
Electronic charge (magnitude)	$q = 1.60 \times 10^{-19}$ C
Electronic rest mass	$m_0 = 9.11 \times 10^{-31}$ kg
Permittivity of free space	$\epsilon_0 = 8.85 \times 10^{-14}$ F/cm $= 8.85 \times 10^{-12}$ F/m
Planck's constant	$h = 6.63 \times 10^{-34}$ J·s $= 4.14 \times 10^{-15}$ eV·s
Room temperature value of kT	$kT = 0.0259$ eV
Speed of light	$c = 2.998 \times 10^{10}$ cm/s
Prefixes:	
1 Å (angstrom) = 10^{-8} cm	milli-, m- = 10^{-3}
1 μm (micron) = 10^{-4} cm	micro-, μ- = 10^{-6}
1 nm = 10^{-7} cm	nano-, n- = 10^{-9}
2.54 cm = 1 in.	pico-, p- = 10^{-12}
1 eV = 1.6×10^{-19} J	kilo-, k- = 10^3
	mega-, M- = 10^6
	giga-, G- = 10^9
A wavelength λ of 1 μm corresponds to a photon energy of 1.24 eV.	